

Application/Control No.	Applicant(s)/Patent under Reexamination							
09/739,817	MIYANO ET AL.							
Examiner	Art Unit							
JOHN J. LEE	2684							

		IS	SUE C	LASSIF	ICATION	1								
01	RIGINAL				CROSS	REFERENCI	E(S)							
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)											
455	277.1	455	562.1	66.1	101									
INTERNATION	AL CLASSIFICATION													
1 0 4 B	1/06													
1 0 4 B	7/00													
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John J. Lee 3/16/2006 (Assistant Examiner) (Date)			~ ~ ~	EDECED F	DUBAN	33	Total Claims Allowed: 2							
	JJ 3, uments Examiner)	120 lole	TEO		Date	O.G. Print Claim(s)	O.G. Print Fi							

Claims renumbered in the same order as presented by applicant							☐ CPA			☐ T.D.			☐ R.1.47					
Final	Original		Final	Original		Final	Original	Final	Original		Final	Original		Final	Original		Final	Original
\vdash	1		-	31			61		91			121			151			181
	2			32			62		92			122			152			182
	3			33			63		93			123			153			183
	4		1	34			64		94			124			154			184
	5			35			65		95			125			155			185
	6			36			66		96			126			156			186
	7			37			67		97			127			157			187
\Box	8			38			68		98			128			158			188
	9			39			69		99			129			159			189
	10		1	40			70		100			130			160			190
	11		2	41			71		101			131			161			191
	12			42			72		102			132			162			192
	13			43			73		103			133			163			193
	14			44			74		104			134			164			194
	15			45			75		105			135			165			195
	_16			46			76		106			136			166			196
	17			47			77		107			137			167			197
	18			48			78		108			138			168			198
	19			49			79		109			139)	169			199
	20			50			80		110			140			170			200
	21			51			81		111		ATT	141			171			201
	22			52			82		112			142			172			202
	23			53			83		113			143			173			203
	24			54			84		114			144			174			204
	25			55			85		115			145			175			205
	26			56			86		116			146			176			206
	27			57			87		117			147			177			207
	28			58			88		118			148			178			208
	29			59			89		119			149			179			209
	30			60			90		120			150			180			210